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Communication

Synthesis of vertically aligned porous silica thin films functionalized by silver ions

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- Abstract: In this work, we have shown the chemical procedure enabling the preparation of the
- ² vertically aligned mesoporous silica containing an pre-assumed concentration of the silver ions
- ³ bonded inside pores via the anchored propyl-carboxyl units. The output materials have been
- electrochemically verified with regard to the synthesis correctness in order to confirm the efficiency
- 5 of the fabrication procedure. The mesostructure has been observed using the transmission electron
- 6 microscope. We have shown, that it is possible to finely tune the functionalization rate during the
- 7 co-condensation procedure.
- **Keywords:** Mesoporous silica thin films; electro-assisted self-assembly; functional materials.

• 1. Introduction

Mesoporous silica thin films build of silicon dioxide (mainly amorphous) are presented in a form 10 of nanometric layers that can be mainly devided into two classes - deposited on various substrates 11 or free-standing [1–4]. These materials have an extraordinary developed surface due to the presence 12 of a vast amount of pores in the structure [5], usually ordered. Depending on the geometry of pores 13 and their mutual location these materials can possess no ordering (have a worm-like structure) or 14 can be 2D structured, 3D cage structured or 3D continuous [6,7]. Moreover, each mentioned type of 15 structure can be divided deeper into numerous subtypes. For example, 2D structured thin films (the 16 most interesting to our group) can possess pores with various diameters, distributed irregularly [8,9] 17 or regularly with possible hexagonal or rectangular arrangement [10-12], laying parallel [13,14] or 18 perpendicular [15] to the surface. 19 In our opinion, the most interesting from the applicative point of view is 2D regular porous 20 thin films containing vertically aligned mesochannels. Such materials can be used as matrices for 21 the fabrication of functional materials with sophisticated structures accompanying unique properties. 22 The most efficient method for their preparation is the electro-assisted self-assembly method (EASA) 23 resulting in the material containing vertically aligned channels ordered in a 2D hexagonal pattern with 24 a pore diameter of about 2 nm and wall thickness of 1nm [16]. The structure of pristine EASA thin 25

²⁶ film (non-functionalized) can be seen in 1a along with the transmission electron microscopy (TEM)

²⁷ photography showing the perfect hexagonal arrangement of the pores possible for obtaining by the

²⁸ mentioned method (1b).

Despite their extraordinary structure, the real potential of porous silica thin films became clear after taking into account the possibility of their functionalization [17–20]. From this point of view





Figure 1. The structure of a vertically aligned porous silica thin films prepared via electro-assisted self-assembly method (EASA): scheme (a) and TEM microphotography (b)



Figure 2. The structure of a vertically aligned porous silica thin films containing silver ions anchored inside pores via propyl-carboxyl units.

³¹ vertically aligned mesoporous silica layer can be treated as a unique template, that can be precisely

modified for particular needs via the deposition of corresponding units (functional groups, molecules, 32 nanoparticles, nanowires, etc). Thanks to the extraordinary high specific surface area, such a matrix 33 can accommodate a huge number of anchored functional groups on its internal pore surface. What is 34 more, we are capable to finely tune their number realizing by it the idea of the "2D solid solvent" [21]. 35 In this study, we present the effective procedure allowing for the fabrication of the vertically 36 aligned mesoporous silica thin films containing silver ions anchored inside pores via propyl-carboxyl 37 units. The structure of assumed material can be seen in fig.2. The number of the silver ions 38 accommodated inside pores can be tuned by the variation in the amount of anchoring propyl-carboxyl 39 units, incorporated in the silica structure during the co-condensation synthesis procedure. The material 40 presented here has great importance as far as antimicrobial layers are concerned. What is more, such 41 compounds can be a starting point for the fabrication of the much more sophisticated nanostructured 42 composite materials, containing metallic nanowires inside pores (regularly 2D distributed), also the 43 multi-layer nanowires (publications in preparation). 44

45 2. Materials and Methods

46 2.1. Characterization methods

The electrodeposition of silica thin films (chronoamperometry with controlled potential) as well as differential pulse anodic stripping voltammetry (DPASV) were carried out using potentiostat/galvanostat SP150 (Biologic) at room temperature in the three-electrode configuration.



Figure 3. The general procedure of synthesis of vertically aligned mesoporous silica thin films with 2D hexagonally arranged pores containing silver ions inside pores with assumed concentration.

The working electrode was a conductive substrate (fluoride-doped tin oxide-covered glass, see next section) in the case of electrodeposition of silica thin films, and the same substrate with deposited thin films for DPASV measurements. As the counter electrode we used platinum plate, while the reference electrode was standard Ag/AgCl. The DPASV measurement was carried out with the 0.1M NaNO₃ electrolyte solution. For synthesis and electrochemical measurements we used custom fabricated Teflon cell, allowing for the application the substrate at the bottom.

The TEM imaging was carried out using the FEI Tecnai G2 20 X-TWIN electron microscope, equipped with emission source LaB6 and CCD camera FEI Eagle 2K.

58 2.2. Synthesis of vertically aligned mesoporous silica thin films functionalized with silver ions

The synthesis of vertically aligned mesoporous silica thin films with 2D hexagonally arranged pores containing silver ions inside pores with assumed concentration can be divided on the 5 steps summarized in the Figure 3.

At the first, the appropriate substrates should be prepared. We used glass plates covered 62 pyrolitycally by fluoride-doped tin oxide (FTO) conductive layer (purchased at 3D-Nano Ltd). It 63 is important to use the pyrolytically layered glass, because only this procedure assures the FTO coating 64 strong enough for the harsh reaction involving in the synthesis procedure. As the first, the substrates 65 were washed mechanically with the use of detergent. Next, they were washed a few times with DI 66 water in the ultrasonic bath following by washing with n-propanol. Finally, FTO glasses were soaked 67 in a 1:1 solution of concentrated HCl and ethanol for 15 minutes and washed a few times by DI water 68 in the ultrasonic bath. Thoroughly cleaned substrates were dried under the flowing of nitrogen and 69 stored under the protective atmosphere. 70

The procedure of electro-generation of functionalized silica thin films (STEP 1) starts with 71 preparing the mixture containing 20 ml of NaNO₃ (Chempur Ltd) solution in H₂O (0.1 M), 20 ml of 72 ethanol, 0.47 g of CTAB (Merk Ltd) and 4 mmolls of the silica presursors mixture: tetraethylorthosilicate 73 (TEOS – Merk Ltd) and 4-(Triethoxysilyl)butyronitrile (BNTES– Merk Ltd). The proportions between 74 the two last compounds defines the doping rates of the final materials (the N number in the fig. 3). 75 In order to yield final molar concentrations of functional units of 10%, 5%, 2.5% and 1.25% (SiO-R 76 molecules in all silica-containing molecules) we assumed following proportions TEOS to BNTES: 9:1, 77 19:1, 39:1 and 79:1 (N numbers of 9, 19, 39 and 79). The mixture were stirred about 15 minutes, till 78 CTAB was dissolved. Next, the ph has been decreased to 3 by means of addition of HCl H2 O (0.1 M). 79 The solution was mixed for three hours. 80

The ordered films were received by applying a cathodic potential of 1.5 V for 20 s against the

Ag/AgCl electrode immersed in a hydrolyzed sol solution. After the thin silica films generation, the

electrode surface was immediately rinsed with water and aged overnight at fixed temperature of 130° C

to fix and harden the newly-obtained mesostructure.

To extract the surfactant-templated film (**STEP 2**), the samples were dipped into an ethanolic solution containing 0.1M HCl and maintained under moderate stirring for 15min. After washing a few times by ethanol, the samples were dried under vacuum for a night.

The materials after this stage contain functional butyronitrile (3-cyanopropyl) groups inside open 88 pores, although silica –OH silanol groups are also presented at the pore surface. The later molecules 89 can react with carbon at the end of butyronitrile groups during hydrolysis (further step) making the aimed anchoring units incapable to bonding silver ions. For this reason, we pasivated surface 91 hydroxyl units by silanation (STEP 3). To this end, we treat the samples with 2% trimethylsilyl chloride 92 (TMSCI - Merk Ltd) in dichloromethane $(CH_2CI_2 - Chempur Ltd)$. The reaction was carried out in the 93 Teflon-Parr autoclave at the temperature of 70°C for 24 hours. After this time and cooling down, the 94 samples were washed a few times with dichloromethane and dried under vacuum at fixed temperature 95 of 100°C overnight. 96 As-prepared materials were hydrolysed in the next step (STEP 4) in order to transform 97

cyanopropyl group into propyl carboxylic acid units, capable for immobilization of silver ions. To do this we applied the solution containing concentrated hydrochloric acid (37% – Chempur Ltd) acetone and water (0.9:0.9:0.2 of volume). The addition of the acetone is a very important in this case, because pores interior is hydrophobic. Similarly to previous step, also in this case the reaction was done in the Teflon-Parr autoclave at the increased temperature for 24 hours. After cooling down, the samples were washed a few times with mixture ow water and acetone and dried under vacuum at fixed temperature of 100°C overnight.

At the final step (STEP 5), the prepared samples were activated with silver ions. This was done 105 by interaction of the pre-fictionalized porous silica matrices containing carboxylic acid anchoring 106 units with the solution of AgNO₃ (Merk Ltd) in water and acetone $(1 \cdot 10^{-2} \text{mol}/\text{dm}^3 \text{ in } 1:1 \text{ mixture of}$ 107 water and acetone). The reaction procedure was the same, as in previous two steps: under increased 108 temperature inside Teflon-Parr autoclave. Here we must mention, that all the activities were carried 109 out in the total darkness, in order to avoid crystallization of the metallic silver in the AgNO₃ solution. 110 After washing a few times with mixture ow water and acetone, and drying, samples were ready. 111 Obtained materials were stored in total darkness under protective atmosphere of argon. 112

Here it is worthy of mentioning, that the final concentration of silver inside silica channels is determined by the concentration of the propyl carboxylic acid units: single anchoring groups is capable for immobilization of the single silver ion, creating silver carbonate molecule. Summing up, we obtained following samples:

- vertically aligned porous silica thin films containing 10% of propyl-silver carbonate units inside
 pore 1 OSiR group per 9 SiO₂ SIL-prop-COOAg 9;
- vertically aligned porous silica thin films containing 5% of propyl-silver carbonate units inside
 pore 1 OSiR group per 19 SiO₂ SIL-prop-COOAg 19;
- vertically aligned porous silica thin films containing 2.5% of propyl-silver carbonate units inside
 pore 1 OSiR group per 39 SiO₂ SIL-prop-COOAg 39;
- vertically aligned porous silica thin films containing 1.25% of propyl-silver carbonate units inside
 pore 1 OSiR group per 79 SiO₂ SIL-prop-COOAg 79.
- **3.** Results and Discussion

The first evidence of the obtained materials' correctness was done by means of TEM microscopy. As it can be seen in Figure 4, all the samples have a correct structure with 2D hexagonal arranged pores, perpendicular to the substrate. The pores diameter is about 2 nm, while inter-planar distance about 3.5 nm, similar to earlier study [16]. No differences between pure silica thin films and fictionalised samples can be seen. Also no agglomerations of the doping agent are visible.



Figure 4. TEM images of the porous silica thin layers unmodified (a) and containing different concentrations of the functional groups (c–e).



Figure 5. Differential pulse anodic stripping voltammetry (DPASV) spectra recorded for silver-functionalized samples: vertically aligned porous silica thin films functionalized by silver ions anchored via propyl-carboxyl units deposited on FTO-covered glass. Samples contain various concentration of the silver carbonate units

The most sensitive technique that is likely to detect even trace amount of the silver ions in the samples is differential pulse anodic stripping voltammetry. Here we must remark, that it is virtually the only method for relative quantification of the silver ions amount. Even X-ray photoelectron spectroscopy (XPS) is not able to detect silver in the vertically aligned porous silica thin films for two reasons: (i) silver-containing specimens have a low photoelectric cross-section and are very hard to detect in small amounts under XPS measurements [22,23] and (ii) porosity of thin films increases the participation of the background signal (the signal originating from the substrate).

For the reason quoted above, we applied DPASV for the verification of the synthesis procedure 138 by measuring the relative amount of the silver in prepared samples, that was applied as a working 139 electrodes. Since the working solution contained no silver ions all the ions detected via the DPASV 140 scan are related to the ones from the functionalization of the working electrode surface. Typical DPASV results for the samples with different amounts of anchored functional groups can be seen in 142 Figure 5. One can see the presence of peaks for all samples at approximately 0.2-0.3V corresponding 143 the most probably to the silver oxidation. Taking under consideration, that this peak is absent for 144 the non-activated films and their surfaces are directly proportional to the assumed concentration of 145 silver-containing groups (see: Figure 6a), we are convinced of this fact, since the surface area under 146 the DPASV peaks is proportional to the charge transported during the possible oxidation process [24]. 147 What is more, the asymmetric peaks profiles indicating irreversibility of the reaction. 148

The peaks positions also depend on the concentration of functional groups, as can be seen in Figure 6b. Dear Professor Walcarius, we would be grateful for your help

I'm not sure, if the following calculations makes sense...Dear Professor, if you think, that yes, wecalculate the ions number also for remaining samples

Plotting the current versus time for the oxidation reaction (during DPASV measurement) (see: 153 Figure.7) and integrating the surface area under the curve one can obtain the charge corresponding 154 to the silver oxidation process. Knowing this value it is possible to estimate the approximate the 155 number of silver ions in one pore. Dividing the charge transferred during oxidation reaction by the 156 elementary charge we are able to obtain the number of electrons involved in the reaction. Assuming 157 Ag(I) configuration of silver in functional units, obtained value is also equal to the number of atoms 158 detected by DPV. In a case of the sample with the highest concentration of silver ions inside pores – 159 sample SIL-prop-COOAg 9 the ions number (N_{ions}) can be calculated as follow: 160

$$N_{ions} = rac{Q_{el.proc}}{q_{el}} = rac{25.8 \cdot 10^{-6} C}{1.6 \cdot 10^{-19} C} = 16.1 \cdot 10^{13},$$





Figure 6. The dependencies of peaks surface areas (a) and peaks positions (b) on the assumed concentration of the silver in the samples



Figure 7. Dependence of current on time during the DPASV measurement for the sample of SIL-prop-COOAg 9 (containing 10% of functional groups) with depicted peak area corresponding to the charge transferred during the electrode reaction

where $Q_{el.vroc}$ is the the charge corresponding to process, and q_{el} is elemental charge.

Dividing this number into the number of pores on the electrode surface we will obtain the approximate minimal number of ions in one pore. The pores density in such kind of thin films is $7,5\cdot10^{12}$ pores per 1 cm² [16].

Dear Professor Walcarius, we have recalculated the density of pores. Taking under consideration hexagonal arrangement and interplannar distance of about 3.5nm, the surface area for single pore is: 3.5x3.5xsin60=10.6 nm2, and this gives 9,4*10to12 pores per 1cm2

The surface area of the working electrode was 0.49 cm^2 , thus the pores number in this area (N_{pores}) was $3,7 \cdot 10^{12}$. This allows for the calculation the number of ions inside single channel according the following formula:

$$N_{ions/channel} = \frac{N_{ions}}{N_{pores}} = \frac{16.1 \cdot 10^{13}}{3.7 \cdot 10^{12}} = 43.5ions/channel$$

It is worth noticing that this amount of ions in a pore is rather only a minimal amount since it 171 is unknown if the electrochemical process was fully quantitative and the real number of ions can be 172 significantly greater. At the same time, obtained here number indicates, that multiple ions can be placed 173 in one pore and their number can be tuned. In principle, it is possible to tune the average number of ions in one pore and use them in some in-pore reaction to obtain nanoparticles or nanowires of the 175 desired size. I'm not sure if we should add this, since this amount is too low to obtain nanocrystals in 176 the pores. Since we have obtained ones, I assume, that the real number is greater. On the other hand, I 177 add comments, that it's only a minimal number. Also, we need a discussion. Maybe it is better to do a 178 separate voltamperogram, but adding one from DPASV we are showing, that it all was done on one sample 180

181 4. Conclusions

In this work, we have reported a synthesis technique for the fabrication of the vertically aligned mesoporous silica thin films functionalized by silver ions inside pores. We have shown electrochemical experiments' results on samples with different concentrations of silver ions inside pores proving, that calibration of silver ions amount is possible as well as multiple ions could be simultaneously placed in one pore. Altogether these statements indicate that obtained materials could be used to obtain nanoparticles or nanowires of the desired size inside pores. Under processing 188 Supplementary Materials: The following are available online at www.mdpi.com/xxx/s1

Author Contributions: Conceptualization: AF, ŁL, ML; data curation: AF, ŁL; funding acquisition: ŁL; project

administration: ŁL; resources: AW, AF, ŁL, ML, NV, PK; software: KC; supervision: AW, LL, NV; validation: ÁW; visualization: AF, ŁL; writing - original draft: AF, ŁL, AW, NV; writing - review & editing: AW, AF, ŁL, ML, NV,

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- 197 Abbreviations
- ¹⁹⁸ The following abbreviations are used in this manuscript:
- 199
- EASA electro-assisted self-assembly
- FTO Fluoride doped Tin Oxide
- CTAB cetyltrimethylammonium bromide
 - TEOS tetraethyl orthosilicate)
 - BNTES butyronitrile triethoxysilane
 - TMSCl trimethylsilyl chloride

201 References

- Kao, K.C.; Lin, C.H.; Chen, T.Y.; Liu, Y.H.; Mou, C.Y. A general method for growing large area mesoporous silica thin films on flat substrates with perpendicular nanochannels. *Journal of the American Chemical Society* 2015, 137, 3779–3782.
- Yeh, Y.Q.; Lin, H.P.; Tang, C.Y.; Mou, C.Y. Mesoporous silica SBA-15 sheet with perpendicular nanochannels.
 Journal of colloid and interface science 2011, 362, 354–366.
- Chen, B.C.; Lin, H.P.; Chao, M.C.; Mou, C.Y.; Tang, C.Y. Mesoporous silica platelets with perpendicular
 nanochannels via a ternary surfactant system. *Advanced Materials* 2004, *16*, 1657–1661.
- Laskowski, L.; Laskowska, M.; Jelonkiewicz, J.; Dulski, M.; Wojtyniak, M.; Fitta, M.; Balanda, M. SBA-15
 mesoporous silica free-standing thin films containing copper ions bounded via propyl phosphonate
 units-preparation and characterization. *Journal of Solid State Chemistry* 2016, 241, 143–151.
- 5. Mezza, P.; Phalippou, J.; Sempere, R. Sol–gel derived porous silica films. *Journal of non-crystalline solids* 1999, 243, 75–79.
- Margolese, D.; Stucky, G.; others. Synthesis of continuous mesoporous silica thin films with
 three-dimensional accessible pore structures. *Chemical Communications* 1998, pp. 2499–2500.
- 7. Lee, U.; Kim, M.H.; Kwon, Y.U.; others. Mesoporous thin films with accessible pores from surfaces. *Bulletin* of the Korean Chemical Society 2006, 27, 808–816.
- Teng, Z.; Zheng, G.; Dou, Y.; Li, W.; Mou, C.Y.; Zhang, X.; Asiri, A.M.; Zhao, D. Highly ordered mesoporous silica films with perpendicular mesochannels by a simple stöber-solution growth approach. *Angewandte Chemie International Edition* 2012, *51*, 2173–2177.
- 9. Robertson, C.; Beanland, R.; Boden, S.A.; Hector, A.L.; Kashtiban, R.J.; Sloan, J.; Smith, D.C.; Walcarius, A.
 Ordered mesoporous silica films with pores oriented perpendicular to a titanium nitride substrate. *Physical*
- 223 *Chemistry Chemical Physics* **2015**, 17, 4763–4770.
- Innocenzi, P.; Malfatti, L.; Kidchob, T.; Falcaro, P. Order-Disorder in Self-Assembled Mesostructured Silica
 Films: A Concepts Review. *Chemistry of Materials* 2009, 21, 2555–2564. doi:10.1021/cm900288x.
- Lee, U.H.; Yang, J.H.; ju Lee, H.; Park, J.Y.; Lee, K.R.; Kwon, Y.U. Facile and adaptable synthesis method of
 mesostructured silica thin films. *Journal of Materials Chemistry* 2008, *18*, 1881. doi:10.1039/b718871d.
- Klotz, M.; Albouy, P.A.; Ayral, A.; Ménager, C.; Grosso, D.; der Lee, A.V.; Cabuil, V.; Babonneau, F.;
 Guizard, C. The True Structure of Hexagonal Mesophase-Templated Silica Films As Revealed by X-ray
 Scattering: Effects of Thermal Treatments and of Nanoparticle Seeding. *Chemistry of Materials* 2000,
- 231 12, 1721–1728. doi:10.1021/cm991198t.

- ²³⁵ Thin Layers, doi:http://dx.doi.org/10.1016/j.tsf.2005.08.357.
- 14. Dourdain, S.; Mehdi, A.; Bardeau, J.; Gibaud, A. Determination of porosity of mesoporous silica thin
 films by quantitative X-ray reflectivity analysis and {GISAXS}. *Thin Solid Films* 2006, 495, 205 209.
 {EMRS} 2005 Symposium ESynthesis, Characterization and Applications of Mesostructured Thin Layers,
 doi:http://dx.doi.org/10.1016/j.tsf.2005.08.356.
- Urbanova, V.; Walcarius, A. Vertically-aligned Mesoporous Silica Films. *Zeitschrift für anorganische und allgemeine Chemie* 2013, 640, 537–546. doi:10.1002/zaac.201300442.
- Walcarius, A.; Sibottier, E.; Etienne, M.; Ghanbaja, J. Electrochemically assisted self-assembly of mesoporous
 silica thin films. *Nature materials* 2007, *6*, 602.
- Innocenzi, P.; Malfatti, L. Mesoporous thin films: properties and applications. *Chemical Society Reviews* 2013, 42, 4198. doi:10.1039/c3cs35377j.
- iung Chao, K.; hung Liu, P.; ying Huang, K. Thin films of mesoporous silica: characterization and
 applications. *Comptes Rendus Chimie* 2005, *8*, 727–739. doi:10.1016/j.crci.2005.01.004.
- Laskowska, M.; Kityk, I.; Dulski, M.; Jędryka, J.; Wojciechowski, A.; Jelonkiewicz, J.; Wojtyniak, M.;
 Laskowski, Ł. Functionalized mesoporous silica thin films as a tunable nonlinear optical material. *Nanoscale* 2017, 9, 12110–12123. doi:10.1039/c7nr02786a.
- Laskowski, Ł.; Laskowska, M.; Vila, N.; Schabikowski, M.; Walcarius, A. Mesoporous Silica-Based Materials
 for Electronics-Oriented Applications. *Molecules* 2019, 24, 2395. doi:10.3390/molecules24132395.
- 253 21. Laskowska, M.; Pastukh, O.; Fedorchuk, A.; Schabikowski, M.; Kowalczyk, P.; Zalasiński, M.; Laskowski,
- Ł. Nanostructured Silica with Anchoring Units: The 2D Solid Solvent for Molecules and Metal Ions.
 International journal of molecular sciences 2020, 21, 8137.
- 256 22. Chastain, J.; King Jr, R.C. Handbook of X-ray photoelectron spectroscopy. *Perkin-Elmer Corporation* 1992, 40, 221.
- Powell, C. Elemental binding energies for X-ray photoelectron spectroscopy. *Applied Surface Science* 1995, 89, 141–149.
- 24. Barón-Jaimez, J.; Joya, M.; Barba-Ortega, J. Anodic stripping voltammetry–ASV for determination of heavy
 metals. Journal of Physics: Conference Series. IOP Publishing, 2013, Vol. 466, p. 012023.
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